74F00 Quad 2-Input NAND Gate

## FAIRCHILD

SEMICONDUCTOR

### 74F00 Quad 2-Input NAND Gate

### **General Description**

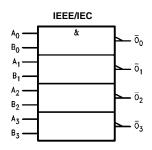
This device contains four independent gates, each of which performs the logic NAND function.

### **Ordering Code:**

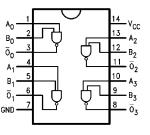
| Order Number | Package Number | Package Description   |  |  |  |  |  |
|--------------|----------------|---|--|--|--|--|--|
| 74F00SC      | M14A           | 14-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-120, 0.150 Narrow |  |  |  |  |  |
| 74F00SJ      | M14D           | 14-Lead Small Outline Package (SOP), EIAJ TYPE II, 5.3mm Wide               |  |  |  |  |  |
| 74F00PC      | N14A           | 14-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300 Wide       |  |  |  |  |  |

Devices also available in Tape and Reel. Specify by appending the suffix letter "X" to the ordering code.

### Logic Symbol



### **Connection Diagram**



### **Unit Loading/Fan Out**

| Pin Names                       | Description | U.L.     | Input I <sub>IH</sub> /I <sub>IL</sub>  |  |
|---------------------------------|-------------|----------|---|--|
|                                 | Description | HIGH/LOW | Output I <sub>OH</sub> /I <sub>OL</sub> |  |
| A <sub>n</sub> , B <sub>n</sub> | Inputs      | 1.0/1.0  | 20 µA/–0.6 mA                           |  |
| Ōn                              | Outputs     | 50/33.3  | –1 mA/20 mA                             |  |

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### Absolute Maximum Ratings(Note 1)

| Storage Temperature                         | -65°C to +150°C                      |  |  |  |
|---|--------------------------------------|--|--|--|
| Ambient Temperature under Bias              | -55°C to +125°C                      |  |  |  |
| Junction Temperature under Bias             | $-55^{\circ}C$ to $+150^{\circ}C$    |  |  |  |
| V <sub>CC</sub> Pin Potential to Ground Pin | -0.5V to +7.0V                       |  |  |  |
| Input Voltage (Note 2)                      | -0.5V to +7.0V                       |  |  |  |
| Input Current (Note 2)                      | -30 mA to +5.0 mA                    |  |  |  |
| Voltage Applied to Output                   |                                      |  |  |  |
| in HIGH State (with $V_{CC} = 0V$ )         |                                      |  |  |  |
| Standard Output                             | –0.5V to V <sub>CC</sub>             |  |  |  |
| 3-STATE Output                              | -0.5V to +5.5V                       |  |  |  |
| Current Applied to Output                   |                                      |  |  |  |
| in LOW State (Max)                          | twice the rated I <sub>OL</sub> (mA) |  |  |  |
| ESD Last Passing Voltage (Min)              | 4000V                                |  |  |  |
|   |                                      |  |  |  |

#### **Recommended Operating** Conditions

| Free Air Ambient Temperature |
|------------------------------|
| Supply Voltage               |

 $0^{\circ}C$  to  $+70^{\circ}C$ +4.5V to +5.5V

Note 1: Absolute maximum ratings are values beyond which the device may be damaged or have its useful life impaired. Functional operation under these conditions is not implied.

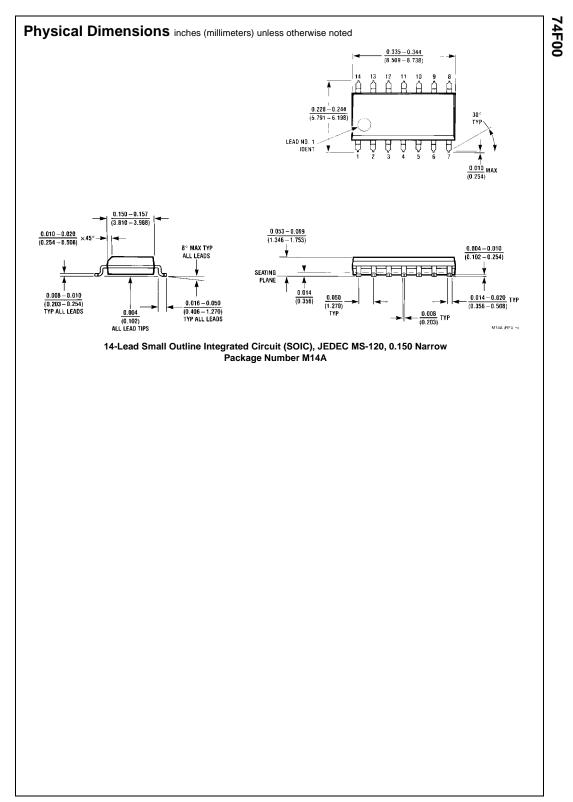
Note 2: Either voltage limit or current limit is sufficient to protect inputs.

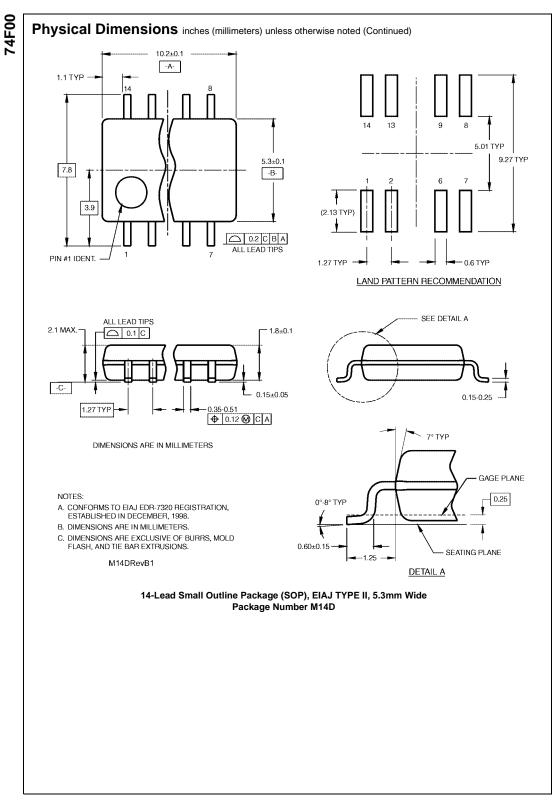
### **DC Electrical Characteristics**

| Symbol           | ol Parameter                    |                     | Min  | Тур | Max  | Units | V <sub>cc</sub> | Conditions                 |  |  |
|------------------|---------------------------------|---------------------|------|-----|------|-------|-----------------|----------------------------|--|--|
| V <sub>IH</sub>  | Input HIGH Voltage              |                     | 2.0  |     |      | V     |                 | Recognized as a HIGH Signa |  |  |
| V <sub>IL</sub>  | Input LOW Voltage               |                     |      |     | 0.8  | V     |                 | Recognized as a LOW Signal |  |  |
| V <sub>CD</sub>  | Input Clamp Diode Voltag        | je                  |      |     | -1.2 | V     | Min             | I <sub>IN</sub> = -18 mA   |  |  |
| V <sub>OH</sub>  | Output HIGH 10% V <sub>CC</sub> |                     | 2.5  |     |      | V     | Min             | I <sub>OH</sub> = -1 mA    |  |  |
|                  | Voltage                         | 5% V <sub>CC</sub>  | 2.7  |     |      |       |                 | $I_{OH} = -1 \text{ mA}$   |  |  |
| V <sub>OL</sub>  | Output LOW<br>Voltage           | 10% V <sub>CC</sub> |      |     | 0.5  | V     | Min             | I <sub>OL</sub> = 20 mA    |  |  |
| IIH              | Input HIGH                      |                     |      |     | 5.0  | μA    | Max             | V <sub>IN</sub> = 2.7V     |  |  |
| I <sub>BVI</sub> | Current<br>Input HIGH Current   |                     |      |     | 7.0  | μA    | Max             | V <sub>IN</sub> = 7.0V     |  |  |
|                  | Breakdown Test                  |                     |      |     |      |       |                 |                            |  |  |
| ICEX             | Output HIGH                     |                     |      |     | 50   | μA    | Max             | $V_{OUT} = V_{CC}$         |  |  |
|                  | Leakage Current                 |                     |      |     |      |       |                 |                            |  |  |
| V <sub>ID</sub>  | Input Leakage                   |                     | 4.75 |     |      | V     | 0.0             | I <sub>ID</sub> = 1.9 μA   |  |  |
|                  | Test                            |                     |      |     |      |       |                 | All other pins grounded    |  |  |
| I <sub>OD</sub>  | Output Leakage                  |                     |      |     | 3.75 | μΑ    | 0.0             | $V_{IOD} = 150 \text{ mV}$ |  |  |
|                  | Circuit Current                 |                     |      |     |      |       |                 | All other pins grounded    |  |  |
| IIL              | Input LOW Current               |                     |      |     | -0.6 | mA    | Max             | $V_{IN} = 0.5V$            |  |  |
| I <sub>OS</sub>  | Output Short-Circuit Curr       | ent                 | -60  |     | -150 | mA    | Max             | V <sub>OUT</sub> = 0V      |  |  |
| I <sub>CCH</sub> | Power Supply Current            |                     |      | 1.9 | 2.8  | mA    | Max             | V <sub>O</sub> = HIGH      |  |  |
| I <sub>CCL</sub> | Power Supply Current            |                     |      | 6.8 | 10.2 | mA    | Max             | $V_{O} = LOW$              |  |  |

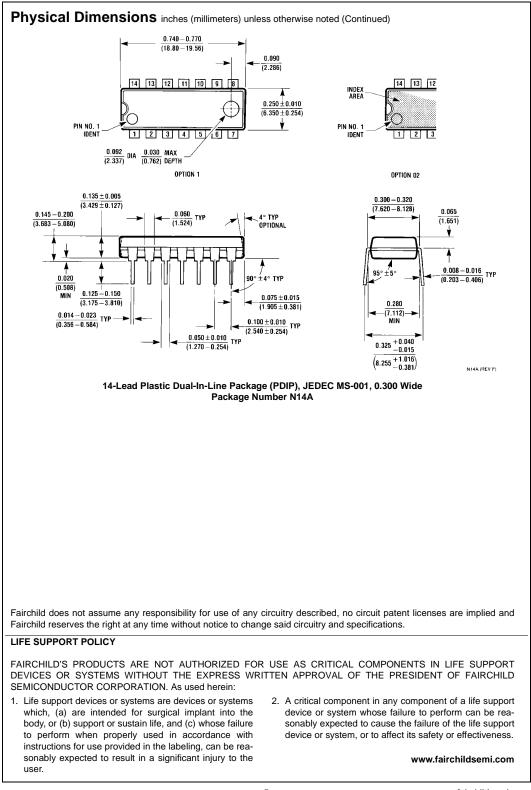
### **AC Electrical Characteristics**

| Symbol           | Parameter                             | $T_{A} = +25^{\circ}C$ $V_{CC} = +5.0V$ $C_{L} = 50 \text{ pF}$ |     |     | $\label{eq:T_A} \begin{split} T_A = -55^\circ C \ to \ +125^\circ C \\ V_{CC} = +5.0V \\ C_L = 50 \ pF \end{split}$ |     | $T_{A} = 0^{\circ}C \text{ to } +70^{\circ}C$ $V_{CC} = +5.0V$ $C_{L} = 50 \text{ pF}$ |     | Units |
|------------------|---------------------------------------|---|-----|-----|---|-----|--|-----|-------|
|                  |                                       | Min   | Тур | Max | Min   | Max | Min  | Max |       |
| t <sub>PLH</sub> | Propagation Delay                     | 2.4   | 3.7 | 5.0 | 2.0   | 7.0 | 2.4  | 6.0 | ns    |
| t <sub>PHL</sub> | $A_n, B_n \text{ to } \overline{O}_n$ | 1.5   | 3.2 | 4.3 | 1.5   | 6.5 | 1.5  | 5.3 | 115   |





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